

IRFI9530GPbF

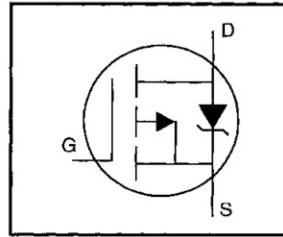
HEXFET® Power MOSFET

- Isolated Package
- High Voltage Isolation = 2.5kVRMS ⑤
- Sink to Lead Creepage Dist. = 4.8mm
- P-Channel
- 175°C Operating Temperature
- Dynamic dv/dt Rating
- Low Thermal Resistance
- Lead-Free

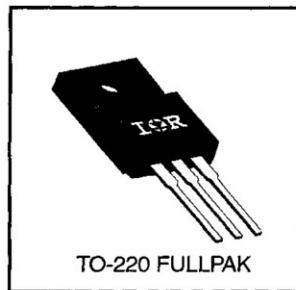
Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.



$V_{DSS} = -100V$
$R_{DS(on)} = 0.30\Omega$
$I_D = -7.7A$



Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ -10 V$	-7.7	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ -10 V$	-5.4	
I_{DM}	Pulsed Drain Current ①	-31	
$P_D @ T_C = 25^\circ C$	Power Dissipation	42	W
	Linear Derating Factor	0.28	W/ $^\circ C$
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy ②	380	mJ
I_{AR}	Avalanche Current ③	-7.7	A
E_{AR}	Repetitive Avalanche Energy ④	4.2	mJ
dv/dt	Peak Diode Recovery dv/dt ⑤	-5.5	V/ns
T_J	Operating Junction and	-55 to +175	$^\circ C$
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1 N•m)	

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	—	3.6	$^\circ C/W$
$R_{\theta JA}$	Junction-to-Ambient	—	—	65	

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International
Rectifier

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-100	—	—	V	$V_{GS}=0\text{V}$, $I_D=-250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	-0.10	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D=-1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.30	Ω	$V_{GS}=-10\text{V}$, $I_D=-4.6\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	-2.0	—	-4.0	V	$V_{DS}=V_{GS}$, $I_D=-250\mu\text{A}$
g_{fs}	Forward Transconductance	3.4	—	—	S	$V_{DS}=-50\text{V}$, $I_D=-4.6\text{A}$ ④
I_{DSS}	Drain-to-Source Leakage Current	—	—	-100	μA	$V_{DS}=-100\text{V}$, $V_{GS}=0\text{V}$
		—	—	-500		$V_{DS}=-80\text{V}$, $V_{GS}=0\text{V}$, $T_J=150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	-100	nA	$V_{GS}=-20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	100		$V_{GS}=20\text{V}$
Q_g	Total Gate Charge	—	—	38	nC	$I_D=-12\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	6.8		$V_{DS}=-80\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	21		$V_{GS}=-10\text{V}$ See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	12	—	ns	$V_{DD}=-50\text{V}$
t_r	Rise Time	—	52	—		$I_D=-12\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	31	—		$R_G=12\Omega$
t_f	Fall Time	—	39	—		$R_D=3.9\Omega$ See Figure 10 ④
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	860	—	pF	$V_{GS}=0\text{V}$
C_{oss}	Output Capacitance	—	340	—		$V_{DS}=-25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	93	—		$f=1.0\text{MHz}$ See Figure 5
C	Drain to Sink Capacitance	—	12	—	pF	$f=1.0\text{MHz}$

Source-Drain Ratings and Characteristics

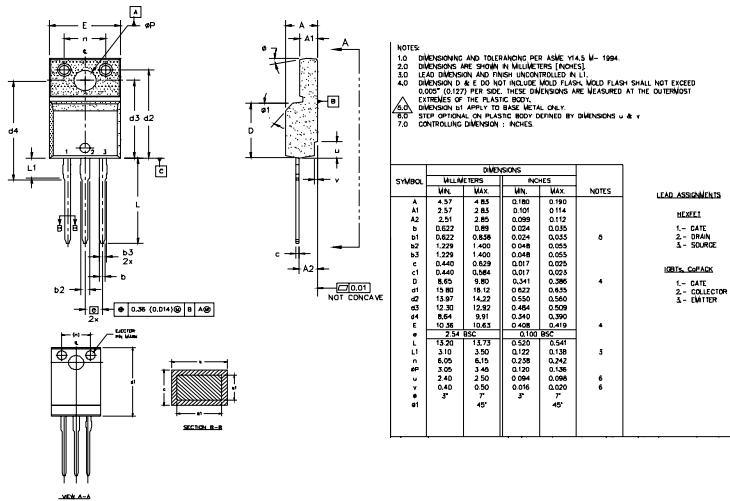
	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	-7.7	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	-31		
V_{SD}	Diode Forward Voltage	—	—	-6.3	V	$T_J=25^\circ\text{C}$, $I_S=-7.7\text{A}$, $V_{GS}=0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	120	240	ns	$T_J=25^\circ\text{C}$, $I_F=-12\text{A}$
Q_{rr}	Reverse Recovery Charge	—	0.46	0.92	μC	$dI/dt=100\text{A}/\mu\text{s}$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ③ $I_{SD}\leq-7.7\text{A}$, $di/dt\leq140\text{A}/\mu\text{s}$, $V_{DD}\leq V_{(\text{BR})\text{DSS}}$, $T_J\leq175^\circ\text{C}$ ⑤ $t=60\text{s}$, $f=60\text{Hz}$
- ② $V_{DD}=-25\text{V}$, starting $T_J=25^\circ\text{C}$, $L=9.6\text{mH}$, $R_G=25\Omega$, $I_{AS}=-7.7\text{A}$ (See Figure 12)
- ④ Pulse width $\leq 300 \mu\text{s}$; duty cycle $\leq 2\%$.

TO-220 Full-Pak Package Outline

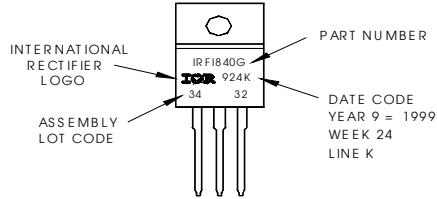
Dimensions are shown in millimeters (inches)



TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRF1840G
WITH ASSEMBLY
LOT CODE 3432
ASSEMBLED ON WW 24 1999
IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line
position indicates "Lead-Free"



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